

FEATURES/BENEFITS

- 5V tolerant inputs and outputs
- 25Ω series resistor for low switching noise
- $10\mu A$ I_{CCQ} quiescent power supply current
- Hot insertable
- 2.0V-3.6V V_{CC} supply operation
- $\pm 12mA$ balanced output drive
- Power down high impedance inputs and outputs
- $t_{PD} = 6.5ns$
- Input hysteresis for noise immunity
- Meets or exceeds JEDEC Standard 36 specifications
- Multiple power and ground pins for low noise
- Operating temperature range:
 $-40^{\circ}C$ to $85^{\circ}C$
- Latch-up performance exceeds 500mA
- ESD performance:
Human body model > 2000V
Machine model > 200V
- Packages available:
56-pin TSSOP
56-pin SSOP

DESCRIPTION

The QS74LCX162827 is a 20-bit buffer that is ideal for driving address and data buses. The 3.3V LCXPlus family features low power, low switching noise, and fast switching speeds for low power portable applications as well as high-end, advanced workstation applications. 5V tolerant inputs and outputs allow this LCXPlus product to be used in mixed 5V and 3.3V applications. The QS74LCX162827 with integrated output resistor is ideally suited for low noise environments where reduced output overshoot and undershoot are critical requirements. Easy board layout is facilitated by the use of flow-through pinouts and byte enable controls provide architectural flexibility for systems designers. To accommodate hot-plug or live insertion applications, this product is designed not to load an active bus when V_{CC} is removed.

Figure 1. Functional Block Diagram

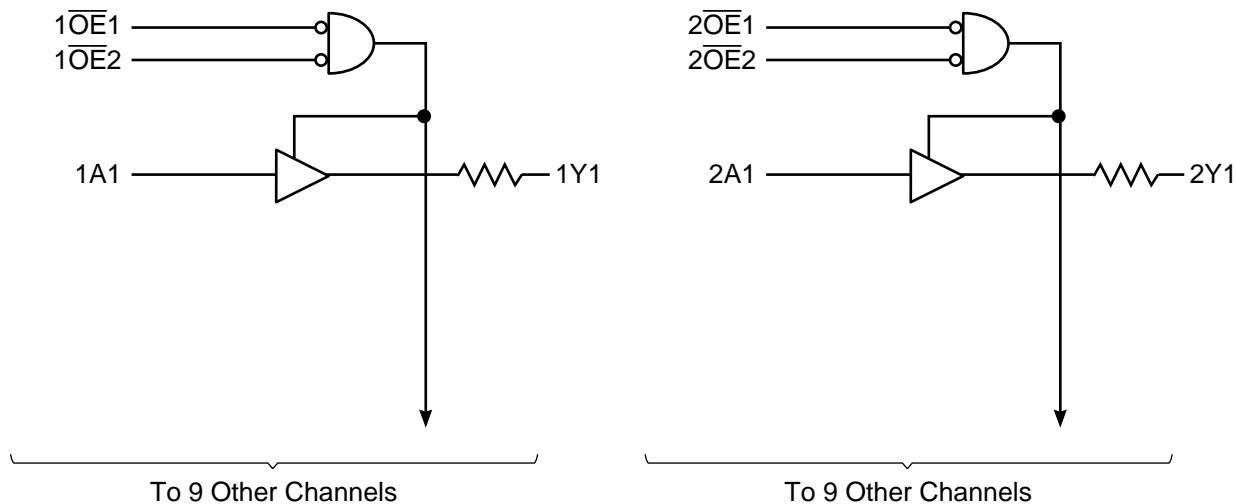


Figure 2. Pin Configuration
(All Pins Top View)

SSOP, TSSOP	
1 \overline{OE}_1	1
1Y1	2
1Y2	3
GND	4
1Y3	5
1Y4	6
V _{CC}	7
1Y5	8
1Y6	9
1Y7	10
GND	11
1Y8	12
1Y9	13
1Y10	14
2Y1	15
2Y2	16
2Y3	17
GND	18
2Y4	19
2Y5	20
2Y6	21
V _{CC}	22
2Y7	23
2Y8	24
GND	25
2Y9	26
2Y10	27
2 \overline{OE}_1	28
	29
	30
	31
	32
	33
	34
	35
	36
	37
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	51
	52
	53
	54
	55
	56
	1 \overline{OE}_2
	1A1
	1A2
	GND
	1A3
	1A4
	V _{CC}
	1A5
	1A6
	1A7
	1A8
	1A9
	1A10
	2A1
	2A2
	2A3
	GND
	2A4
	2A5
	2A6
	V _{CC}
	2A7
	2A8
	GND
	2A9
	2A10
	2 \overline{OE}_2

Table 1. Pin Description

Name	Description
x \overline{OE}_x	Output Enables
xAx	Data Inputs
xYx	Data Outputs

Table 2. Function Table

Inputs				Function
\overline{OE}_1	\overline{OE}_2	xAx	xYx	
L	L	L	L	Enabled
L	L	H	H	Enabled
H	—	—	Hi-Z	High Impedance
—	H	—	Hi-Z	High Impedance

Table 3. Capacitance

Symbol	Pins	Typ	Unit	Conditions
C_{IN}	Input Capacitance	7.0	pF	$V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz$
$C_{I/O}$	I/O Capacitance	8.0	pF	$V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz$
C_{PD}	Power Dissipation Capacitance	25	pF	$V_{CC} = 3.3V, V_{IN} = 0 \text{ or } V_{CC}$ $f = 10MHz$

Note: Capacitance is characterized but not production tested.

Table 4. Absolute Maximum Ratings

Supply Voltage to Ground	-0.5V to 7.0V
DC Output Voltage V_{OUT}	
Outputs HIGH-Z	-0.5V to 7.0V
Outputs Active	-0.5V to $V_{CC} + 0.5V$
DC Input Voltage V_{IN}	-0.5V to 7.0V
DC Input Diode Current with $V_{IN} < 0$	-50mA
DC Output Diode Current	
$V_O < 0$	-50mA
$V_O > V_{CC}$	50mA
DC Output Source/Sink Current (I_{OH}/I_{OL})	±50mA
DC Supply Current per Supply Pin	±100mA
DC Ground Current per Ground Pin	±100mA
T_{STG} Storage Temperature	-65°C to 150°C

Note: Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to this device resulting in functional or reliability type failures.

Table 5. Recommended Operating Conditions

Symbol	Parameter		Min	Max	Unit
V_{CC}	Supply Voltage, Operating		2.0	3.6	V
	Supply Voltage, Data Retention Only		1.5	3.6	
V_{IN}	Input Voltage		0	5.5	V
V_{OUT}	Output Voltage in Active State		0	V_{CC}	V
V_{OUT}	Output Voltage in "OFF" State		0	5.5	V
I_{OH}/I_{OL}	Output Current		$V_{CC} = 3.0 - 3.6V$	—	mA
			$V_{CC} = 2.7V$	±6	
$\Delta t/\Delta v$	Input Transition Slew Rate		—	10	ns/V
T_A	Operating Free Air Temperature		-40	85	°C

Table 6. DC Electrical Characteristics Over Operating RangeIndustrial Temperature Range, $T_A = -40^\circ\text{C}$ to 85°C

Symbol	Parameter	Test Conditions ⁽¹⁾	Min	Typ ⁽²⁾	Max	Unit
V_{IH}	Input HIGH Voltage	Logic HIGH for All Inputs	2.0	—	—	V
V_{IL}	Input LOW Voltage	Logic LOW for All Inputs	—	—	0.8	V
V_{OH}	Output HIGH Voltage	$V_{CC} = 2.7\text{V}$, $I_{OH} = -100\mu\text{A}$ $V_{CC} = 3.0\text{V}$, $I_{OH} = -12\text{mA}$ $V_{CC} = 3.0\text{V}$, $I_{OH} = -18\text{mA}$	$V_{CC}-0.2$ 2.4 2.2	— — —	— — —	V
V_{OL}	Output LOW Voltage	$V_{CC} = 2.7\text{V}$, $I_{OL} = 100\mu\text{A}$ $V_{CC} = 3.0\text{V}$, $I_{OL} = 12\text{mA}$ $V_{CC} = 3.0\text{V}$, $I_{OL} = 18\text{mA}$	— — —	— — —	0.2 0.55 0.8	V
R_{OUT}	Output Resistance	$V_{CC} = 3.0\text{V}$, $I_{OL} = 12\text{mA}$	—	28	—	Ω
ΔV_T	Input Hysteresis ⁽³⁾	$V_{TLH} - V_{THL}$ for All Inputs	—	150	—	mV
I_I	Input Leakage Current	$V_{CC} = \text{Max.}$, $V_I = 0\text{V}$, $V_I = 5.5\text{V}$	—	—	± 1.0	μA
I_{OZ}	High-Z I/O Leakage	$V_{CC} = \text{Max.}$, $V_O = 0\text{V}$ $V_O = 5.5\text{V}$, $V_I = V_{IH}$ or V_{IL}	—	—	± 1.0	μA
I_{OS}	Short Circuit Current ^(3,4)	$V_{CC} = 3.6\text{V}$, $V_O = \text{GND}$	-60	—	-200	mA
I_{OR}	Current Drive	$V_{CC} = 3.6\text{V}$, $V_{OUT} = 2.0\text{V}$	40	—	—	mA
I_{OFF}	Power Off Leakage	$V_{CC} = 0\text{V}$, V_I or $V_O = 5.5\text{V}$	—	—	10	μA
V_{IK}	Input Clamp Voltage	$V_{CC} = 2.7\text{V}$, $I_{IN} = -18\text{mA}$	—	-0.7	-1.2	V

Notes:

- For conditions shown as Min. or Max., use appropriate value specified under Recommended Operating Conditions for the appropriate device type.
- Typical values are at $V_{CC} = 3.3\text{V}$, and $T_A = 25^\circ\text{C}$.
- These parameters are guaranteed by characterization, but not production tested.
- Not more than one output should be tested at one time. Duration of test should not exceed one second.

Table 7. Power Supply Characteristics

Symbol	Parameter	Test Conditions ⁽¹⁾	Typ ⁽²⁾	Max	Unit
I _{CC}	Quiescent Power Supply Current	V _{CC} = 3.6V, Freq = 0 V _{IN} = GND or V _{CC}	0.1	10	µA
ΔI _{CC}	Supply Current per Input @ TTL HIGH	V _{CC} = 3.6V, V _{IN} = V _{CC} -0.6V ⁽³⁾	2.0	30	µA
I _{CCD}	Supply Current per Input per MHz ⁽⁴⁾	V _{CC} = 3.6V, Outputs Open One Bit Toggling @ 50% Duty Cycle xOE = GND	65	100	µA/MHz
I _C	Total Power Supply Current ⁽⁶⁾	V _{CC} = 3.6V, Outputs Open One Bit Toggling @ 50% Duty Cycle xOE = GND, f = 10MHz	V _{IN} = V _{CC} -0.6V V _{IN} = GND	0.5 ⁽⁵⁾	0.8 ⁽⁵⁾ mA
		V _{CC} = 3.6V, Outputs Open Twenty Bits Toggling @ 50% Duty Cycle xOE = GND, f = 2.5MHz	V _{IN} = V _{CC} -0.6V V _{IN} = GND	3.3 ⁽⁵⁾	5.4 ⁽⁵⁾

Notes:

- For conditions shown as Min. or Max., use the appropriate values specified under Recommended Operating Conditions for applicable device type.
- Typical values are at V_{CC} = 3.3V, 25°C ambient.
- Per TTL driven input. All other inputs at V_{CC} or GND.
- This parameter is not directly testable, but is derived for use in total power supply calculations.
- Values for these conditions are examples of the I_{CC} formula. These limits are guaranteed by design but not tested.
- I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}.

$$I_C = I_{CCQ} + \Delta I_{CC} D_H N_T + I_{CCD} f N_O.$$

I_{CCQ} = Quiescent Current (I_{CC1}, I_{CC2}, and I_{CC3}).

ΔI_{CC} = Power Supply Current for a TTL-High Input (V_{IN} = V_{CC}-0.6V).

D_H = Duty Cycle for TTL High Inputs.

N_T = Number of TTL High Inputs.

I_{CCD} = Dynamic Current Caused by an Input Transition Pair (HLH or LHL).

f = Average Switching Frequency per Output

N_O = Number of Outputs Switching

Table 8. Dynamic Switching Characteristics⁽¹⁾

Symbol	Parameter	Conditions	V _{CC} (V)	T _A = 25°C	Units
				Typical	
V _{OLP}	Quiet Output Dynamic Peak V _{OL}	C _L = 30pF, V _{IH} = 3.3V, V _{IL} = 0V	3.3	0.8	V
V _{OLV}	Quiet Output Dynamic Valley V _{OL}	C _L = 30pF, V _{IH} = 3.3V, V _{IL} = 0V	3.3	0.8	V

Note:

- Characterized but not production tested.

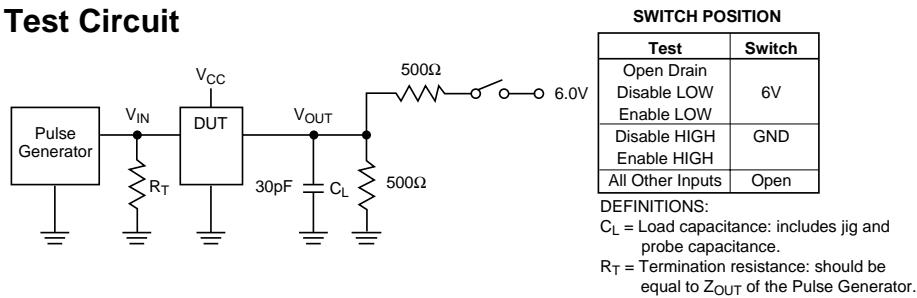
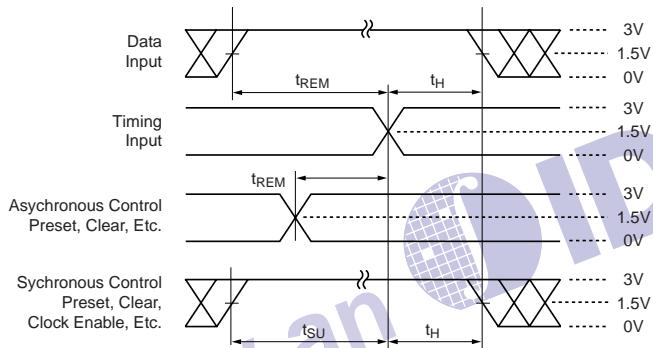
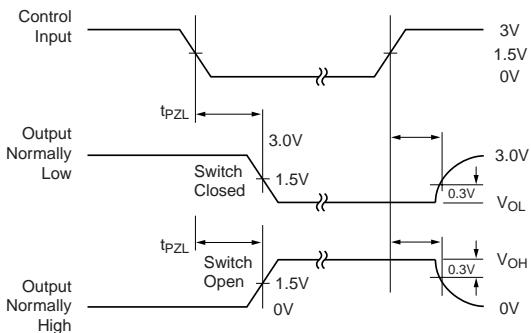
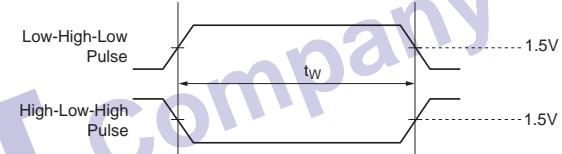
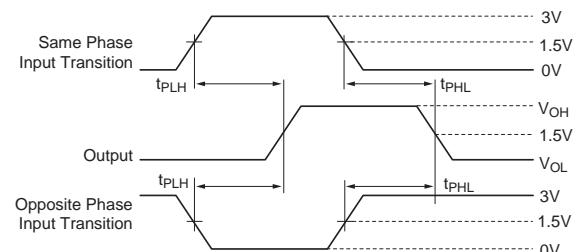
Table 10. Switching Characteristics Over Operating RangeIndustrial Temperature Range, $T_A = -40^\circ\text{C}$ to 85°C . $C_{\text{LOAD}} = 30\text{pF}$, $R_{\text{LOAD}} = 500\Omega$ unless otherwise noted.

Symbol	Parameter⁽¹⁾	Condition	$V_{\text{CC}} = 3.3 \pm 0.3\text{V}$		$V_{\text{CC}} = 2.7\text{V}^{(2)}$		Unit
			Min	Max	Min	Max	
t_{PLH} t_{PHL}	Propagation Delay xAx to xYx	$C_L = 30\text{pF}$ $R_L = 500\Omega$	1.5	6.5	1.5	8.0	ns
t_{PZH} t_{PZL}	Output Enable Time $x\overline{OE}$ to xYx	$C_L = 30\text{pF}$ $R_L = 500\Omega$	1.5	9.5	1.5	11.0	ns
t_{PHZ} t_{PLZ}	Output Disable Time ⁽²⁾ $x\overline{OE}$ to xYx	$C_L = 5\text{pF}^{(2)}$ $R_L = 500\Omega$	1.5	8.5	1.5	10.0	ns
		$C_L = 30\text{pF}$ $R_L = 500\Omega$	1.5	10.0	1.5	11.5	ns
$t_{\text{SK(O)}}$	Output skew		—	0.5	—	—	ns

Notes:

1. Minimum limits guaranteed but not production tested. See test circuit and waveforms.
2. This condition is guaranteed by characterization.
3. Skew between any two outputs of the same package switching in the same direction.
This parameter is guaranteed by characterization.

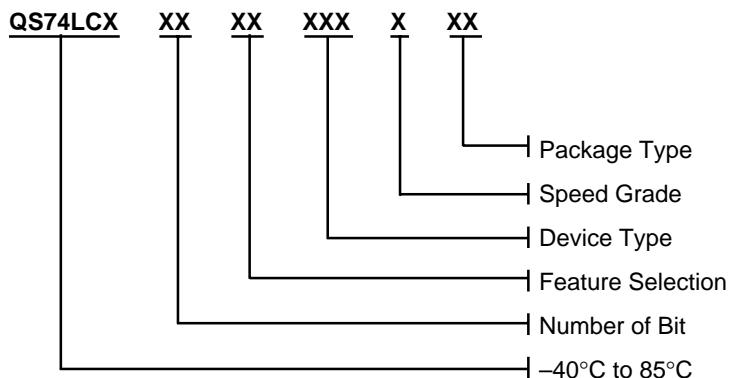
TEST CIRCUIT AND WAVEFORMS

Figure 3. Test Circuit**Figure 4. Setup, Hold, and Release Timing****Figure 5. Enable and Disable Timing****Figure 6. Pulse Width****Figure 7. Propagation Delay**

Notes:

1. Input Control Enable = LOW and Input Control Disable = HIGH.
2. Pulse Generator for All Pulses: Rate $\leq 1.0\text{MHz}$;
 $Z_{OUT} \leq 50\Omega$; $t_F, t_R \leq 2.5\text{ns}$.

ORDERING INFORMATION



Device Type:

827

Speed Grades:

Blank – Standard

Package Type:

PV – SSOP, 300 mil

PA – TSSOP, 240 mil

Feature Selection:

2 – Output Resistor

Number of Bit:

16 – 20-Bit

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